

PCN# 20181106001.1
Qualification of TI Philippines as an additional
Assembly and Test Site for select devices
Change Notification / Sample Request

Date: November 07, 2018

To: Newark/Farnell PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (PCN_ww_admin_team@list.ti.com).

Sincerely,
PCN Team
SC Business Services

20181106001.3
Attachments1

Products Affected:

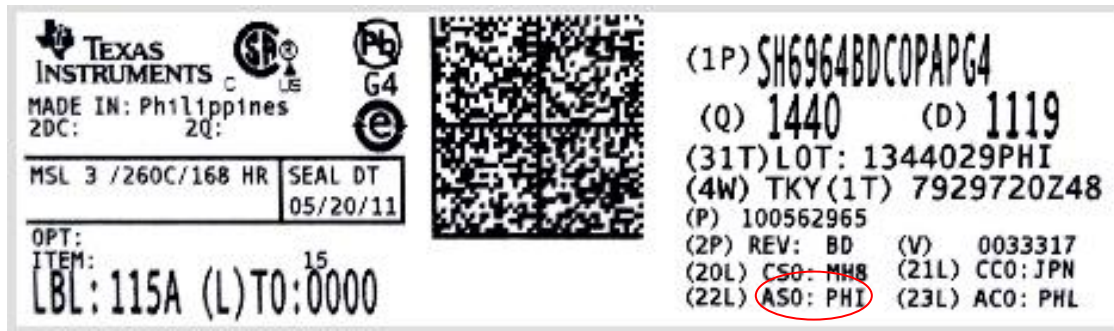
The devices listed on this page are a subset of the complete list of affected devices. According to our records, you have purchased these device within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
TLV2241IDBVT	null
TLV2401IDBVT	null

Details of this Product Discontinuance follow on the next page(s).

PCN Number:	20181106001.1		PCN Date:	Nov 07, 2018												
Title:	Qualification of TI Philippines as an additional Assembly and Test Site for select devices															
Customer Contact:	PCN Manager	Dept:	Quality Services													
Proposed 1st Ship Date:	Feb 07, 2019	Estimated Sample Availability:	Date Provided at Sample request													
Change Type:																
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Design	<input type="checkbox"/>	Wafer Bump Site											
<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Data Sheet	<input type="checkbox"/>	Wafer Bump Material											
<input checked="" type="checkbox"/>	Assembly Materials	<input type="checkbox"/>	Part number change	<input type="checkbox"/>	Wafer Bump Process											
<input type="checkbox"/>	Mechanical Specification	<input checked="" type="checkbox"/>	Test Site	<input type="checkbox"/>	Wafer Fab Site											
<input checked="" type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process	<input type="checkbox"/>	Wafer Fab Materials											
				<input type="checkbox"/>	Wafer Fab Process											
PCN Details																
Description of Change:																
Texas Instruments Incorporated is announcing the qualification TI Philippines as Additional Assembly and Test Site for select devices listed in the "Product Affected" Section. Current assembly sites and Material differences are as follows.																
<table border="1"> <thead> <tr> <th>Assembly Site</th> <th>Assembly Site Origin</th> <th>Assembly Country Code</th> <th>Assembly Site City</th> </tr> </thead> <tbody> <tr> <td>Lingsen</td> <td>LIN</td> <td>TWN</td> <td>Taichung</td> </tr> <tr> <td>TI Philippines</td> <td>PHI</td> <td>PHL</td> <td>Baguio City</td> </tr> </tbody> </table>					Assembly Site	Assembly Site Origin	Assembly Country Code	Assembly Site City	Lingsen	LIN	TWN	Taichung	TI Philippines	PHI	PHL	Baguio City
Assembly Site	Assembly Site Origin	Assembly Country Code	Assembly Site City													
Lingsen	LIN	TWN	Taichung													
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Material Differences:																
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	LIN	PHI														
Mount Compound	0003C10332	4207123														
Mold compound	0011G60007	4222198														
Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ.																
Reason for Change:																
Continuity of supply.																
Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):																
None																
Anticipated impact on Material Declaration																
<input type="checkbox"/>	No Impact to the Material Declaration	<input checked="" type="checkbox"/>	Material Declarations or Product Content reports are driven from production data and will be available following the production release. Upon production release the revised reports can be obtained from the TI Eco-Info website . There is no impact to the material meeting current regulatory compliance requirements with this PCN change.													
Changes to product identification resulting from this PCN:																
<table border="1"> <thead> <tr> <th>Assembly Site</th> <th>Assembly Site Origin (22L)</th> <th>ASO:</th> </tr> </thead> <tbody> <tr> <td>Lingsen</td> <td>Assembly Site Origin (22L)</td> <td>LIN</td> </tr> <tr> <td>TI Philippines</td> <td>Assembly Site Origin (22L)</td> <td>PHI</td> </tr> </tbody> </table>					Assembly Site	Assembly Site Origin (22L)	ASO:	Lingsen	Assembly Site Origin (22L)	LIN	TI Philippines	Assembly Site Origin (22L)	PHI			
Assembly Site	Assembly Site Origin (22L)	ASO:														
Lingsen	Assembly Site Origin (22L)	LIN														
TI Philippines	Assembly Site Origin (22L)	PHI														

Sample product shipping label (not actual product label)



Product Affected:

TLV2241IDBVR	TLV2401CDBVR	TLV2401IDBVRG4
TLV2241IDBVRG4	TLV2401CDBVT	TLV2401IDBVT
TLV2241IDBVT	TLV2401IDBVR	TLV2401IDBVTG4

Qualification Report
TIPI SOT: Phase-1 (5pin DBV)
Approve Date 25-Sep-2015

Product Attributes

Attributes	Qual Device: TPS76933DBVR
Assembly Site	TIPI
Package Family	SOT
Flammability Rating	UL 94 V-0
Wafer Fab Supplier	DL-LIN
Wafer Fab Process	LBC3S

- QBS: Qual By Similarity
- Qual Device TPS76933DBVR is qualified at LEVEL1-260CG

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TPS76933DBVR
AC	Autoclave 121C	96 Hours	3/231/0
CDM	ESD - CDM	1500 V	3/9/0
DS	Die Shear	-	3/30/0
ED	Electrical Characterization, side by side	Per Datasheet Parameters	Pass
FLAM	Flammability (UL 94V-0)	--	3/15/0
HAST	Biased HAST, 130C/85%RH	96 Hours	3/231/0
HBM	ESD - HBM	4000 V	3/9/0
HTOL	Life Test, 150C	300 Hours	3/230/0
HTSL	High Temp Storage Bake 170C	420 Hours	3/231/0
LI	Lead Fatigue	Leads	3/66/0
LI	Lead Pull to Destruction	Leads	3/66/0
MISC	Salt Atmosphere	24 Hours	3/66/0
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	Pass
MSL	Moisture Sensitivity, JEDEC	Level 1-260C	3/36/0
PD	Physical Dimensions	(per mechanical drawing)	3/15/0

Type	Test Name / Condition	Duration	Qual Device: TPS76933DBVR
PKG	Lead Finish Adhesion	Leads	3/45/0
SD	Solderability	8 Hours Steam Age	3/66/0
TC	Temperature Cycle, -65/150C	500 Cycles	3/231/0
VM	Visual / Mechanical	(per mfg. Site specification)	3/984/0
VM	Visual Quality Reliability Inspection	Post Autoclave	3/6/0
VM	Visual Quality Reliability Inspection	Post Biased HAST	3/6/0
VM	Visual Quality Reliability Inspection	Post Temperature Cycle	3/6/0
WBP	Bond Pull	Wires	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0
XRAY	X-ray	(top side only)	3/15/0

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JEDEC : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

THIS INFORMATION RELATING TO QUALITY AND RELIABILITY IS PROVIDED "AS IS." Product information detailed in this report may not accurately reflect TI's current product materials, processes and testing used in the construction of the TI products. Customers are solely responsible to conduct sufficient engineering and additional qualification testing to determine whether a device is suitable for use in their applications. Using TI products outside limits stated in TI's datasheet may void TI's warranty. See TI's Terms of Sale at "<http://www.ti.com/lsds/ti/legal/termsofsale.page>"

Qualification Report

SOT Etched to Stamped Qualification

Approve Date 16-Mar-2017

Product Attributes

Attributes	Qual Device: TPS2051CDBVR	Qual Device: TPS76933DBVR
	Assembly Site	TIPI
Package Family	SOT-23	SOT
Flammability Rating	UL 94 V-0	UL 94 V-0
Wafer Fab Supplier	RFAB	DL-LIN-2
Wafer Fab Process	LBC7XDCU	LBC3S

- Qual Device TPS2051CDBVR is qualified at LEVEL2-260C

- Qual Device TPS76933DBVR is qualified at LEVEL1-260CG

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TPS2051CDBVR	Qual Device: TPS76933DBVR
			DS	Die Shear
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	Pass	Pass
MSL	Moisture Sensitivity, JEDEC	Level 1-260C	-	3/36/0
MSL	Moisture Sensitivity, JEDEC	Level 2-260C	3/36/0	-
SD	Solderability	8 Hours Steam Age	3/66/0	3/66/0
TC	Temperature Cycle, -65/150C	500 Cycles	3/231/0	3/231/0
WBP	Bond Pull	Wires	3/228/0	3/228/0

Type	Test Name / Condition	Duration	Qual Device: <u>TPS2051CDBVR</u>	Qual Device: <u>TPS76933DBVR</u>
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0
XRAY	X-ray	(top side only)	3/15/0	3/15/0

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
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Green/Pb-free Status:
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For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com